Chip Monolithic Ceramic Capacitors



Safety Standard Certified Type GF (IEC60384-14 Class Y2, X1/Y2)

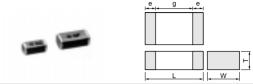
■ Features

- Available for equipment based on IEC/EN60950 and UL1950. Besides, the GA352/355 types are available for equipment based on IEC/EN60065, UL1492, and UL6500
- 2. The type GF can be used as a Y2-class capacitor.
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- 4. +125 degree C guaranteed
- 5. Only for reflow soldering
- 6. The low-profile type (thickness: 1.5mm max.) is available. Fit for use on thinner type equipment.

■ Applications

- Ideal for use on line filters and couplings for DAA modems without transformers
- 2. Ideal for use on line filters for information equipment
- Ideal for use as Y capacitor or X capacitor for various switching power supplies (GA352/355 types only)

Do not use these products in any Automotive Power train or Safety equipment including Battery charger for Electric Vehicles and Plug-in Hybrid. Only Murata products clearly stipulated as "for Automotive use" on its catalog can be used for automobile applications such as Power train and Safety equipment.



Part Number	Dimensions (mm)					
Part Number	L	W	T	e min.	g min.	
GA342A			1.0 +0, -0.3			
GA342D	4.5 ±0.3	2.0 ±0.2	2.0 ±0.2*		2.5	
GA342Q			1.5 +0, -0.3	0.3		
GA352Q		2.8 ±0.3	1.5 +0, -0.3	0.3		
GA355D	5.7 ±0.4	5.0 ±0.4	2.0 +0, -0.3		4.0	
GA355Q		3.0 <u>1</u> 0.4	1.5 +0, -0.3			

^{*} GA342D1X: 2.0±0.3

■ Standard Certification

	Standard		Status of C	ertification	Rated	
	No.	Class Size: 4.5×2.0mm		Size: 5.7×2.8mm and over	Voltage	
UL	UL1414	X1, Y2	_	0		
UL	UL 60950-1	_	0	_	AC250V	
VDE	IEC 60384-14	X1, Y2	_	0	(r.m.s.)	
SEMKO	EN 60384-14	Y2	0	0		

Applications		
Size	Switching power supplies	Communication network devices such as a modem
4.5×2.0mm	_	0
5.7×2.8mm and over	0	0

Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA342D1XGF100JY02L	AC250 (r.m.s.)	SL (JIS)	10 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF120JY02L	AC250 (r.m.s.)	SL (JIS)	12 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF150JY02L	AC250 (r.m.s.)	SL (JIS)	15 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF180JY02L	AC250 (r.m.s.)	SL (JIS)	18 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342D1XGF220JY02L	AC250 (r.m.s.)	SL (JIS)	22 ±5%	4.5	2.0	2.0	2.5	0.3 min.
GA342A1XGF270JW31L	AC250 (r.m.s.)	SL (JIS)	27 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF330JW31L	AC250 (r.m.s.)	SL (JIS)	33 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF390JW31L	AC250 (r.m.s.)	SL (JIS)	39 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF470JW31L	AC250 (r.m.s.)	SL (JIS)	47 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF560JW31L	AC250 (r.m.s.)	SL (JIS)	56 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF680JW31L	AC250 (r.m.s.)	SL (JIS)	68 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342A1XGF820JW31L	AC250 (r.m.s.)	SL (JIS)	82 ±5%	4.5	2.0	1.0	2.5	0.3 min.
GA342QR7GF101KW01L	AC250 (r.m.s.)	X7R (EIA)	100 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342QR7GF151KW01L	AC250 (r.m.s.)	X7R (EIA)	150 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA342DR7GF221KW02L	AC250 (r.m.s.)	X7R (EIA)	220 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA342DR7GF331KW02L	AC250 (r.m.s.)	X7R (EIA)	330 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA342QR7GF471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GA352QR7GF471KW01L	AC250 (r.m.s.)	X7R (EIA)	470 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA342QR7GF681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	4.5	2.0	1.5	2.5	0.3 min.

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Part Number	Rated Voltage (V)	TC Code (Standard)	Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)
GA352QR7GF681KW01L	AC250 (r.m.s.)	X7R (EIA)	680 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA342DR7GF102KW02L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	4.5	2.0	2.0	2.5	0.3 min.
GA352QR7GF102KW01L	AC250 (r.m.s.)	X7R (EIA)	1000 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA352QR7GF152KW01L	AC250 (r.m.s.)	X7R (EIA)	1500 ±10%	5.7	2.8	1.5	4.0	0.3 min.
GA355QR7GF182KW01L	AC250 (r.m.s.)	X7R (EIA)	1800 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355QR7GF222KW01L	AC250 (r.m.s.)	X7R (EIA)	2200 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355QR7GF332KW01L	AC250 (r.m.s.)	X7R (EIA)	3300 ±10%	5.7	5.0	1.5	4.0	0.3 min.
GA355DR7GF472KW01L	AC250 (r.m.s.)	X7R (EIA)	4700 ±10%	5.7	5.0	2.0	4.0	0.3 min.

No.	Ite	m	Specifications	Test Method		
1	Operating Temperatur	re Range	−55 to +125°C	-		
2	Appearan	се	No defects or abnormalities	Visual inspection		
3	Dimension	าร	Within the specified dimensions	Using calipers and micrometers		
4	Diologatria			No failure should be observed when voltage in table is applied between the terminations for 60±1 sec., provided the charge/discharge current is less than 50mA.		
4	Dielectric	tric Strength No defects or abnormalities	Test Voltage Type GB DC1075V Type GC/GD AC1500V (r.m.s.) Type GF AC2000V (r.m.s.)			
5	Pulse Volt (Application GD/GF)		No self healing breakdowns or flash-overs have taken place in the capacitor.	10 impulse of alternating polarity is subjected. (5 impulse for each polarity) The interval between impulse is 60 sec. Applied Pulse: 1.2/50µs Applied Voltage: 2.5kVo-p		
6	Insulation R (I.R.)	esistance	More than $6{,}000M\Omega$	The insulation resistance should be measured with DC500±50V and within 60±5 sec. of charging.		
7	Capacitan	ice	Within the specified tolerance			
8	Dissipation 3 Factor (D.F.) Q		Char. Specification X7R D.F.≦0.025 SL Q≥400+20C*² (C<30pF)	The capacitance/Q/D.F. should be measured at a frequency of 1±0.2kHz (SL char.: 1±0.2MHz) and a voltage of AC1±0.2V (r.m.s.)		
9	Capacitance 9 Temperature Characteristics		Char. Capacitance Change X7R Within ±15% Temperature characteristic guarantee is −55 to +125°C Char. Temperature Coefficient SL +350 to −1000ppm/°C Temperature characteristic guarantee is +20 to +85°C	The capacitance measurement should be made at each step specified in Table. Step Temperature (°C) 1 25±2 (20±2 for SL char.) 2 Min. Operating Temp.±3 3 25±2 (20±2 for SL char.) 4 Max. Operating Temp.±2 5 25±2 (20±2 for SL char.) SL char.: The capacitance should be measured at even 85°C between step 3 and step 4. • Pretreatment for X7R char. Perform a heat treatment at 150 [±] 10°C for 60±5 min. and then let sit for 24±2 hrs. at room condition*1.		
		Appearance	No defects or abnormalities	As in Fig., discharge is made 50 times at 5 sec. intervals from the capacitor (Cd) charged at DC voltage of specified.		
		I.R.	More than 1,000MΩ			
10	Discharge Test (Application: Type GC)	est Application: Dielectric	R3 T 10kV V Cd Ct R2 Ct: Capacitor under test Cd: 0.001μF R1: 1,000Ω R2: 100ΜΩ R3: Surge resistance			
11	Adhesive of Termina		No removal of the terminations or other defect should occur.	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 1. Then apply 10N force in the direction of the arrow. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.		

^{*1 &}quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa *2 "C" expresses nominal capacitance value (pF).

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No.	Ite	em	Specifications	Test Method
	Appearance Capacitance		No defects or abnormalities Within the specified tolerance	Solder the capacitor to the test jig (glass epoxy board). The capacitor should be subjected to a simple harmonic motion
12	Vibration Resistance	D.F. Q	Char. Specification X7R D.F.≤0.025 SL Q≥400+20C*² (C<30pF)	having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.). Solder resist Glass Epoxy Board
			No marking defects	Solder the capacitor to the testing jig (glass epoxy board) shown in Fig. 2. Then apply a force in the direction shown in Fig. 3. The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defeats such as best shock.
13	Deflection	n	LXW Dimension (mm) (mm) a b c d 4.5×2.0 3.5 7.0 2.4 4.5×3.2 3.5 7.0 3.7 5.7×2.8 4.5 8.0 3.2 5.7×5.0 4.5 8.0 5.6 Fig. 2	defects such as heat shock. 20 50 Pressurizing speed: 1.0mm/s Pressurize Pressurize Flexure=1 Capacitance meter (in mm) Fig. 3
14	Solderabi Terminati	•	75% of the terminations are to be soldered evenly and continuously.	Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Immerse in solder solution for 2±0.5 sec. Immersing speed: 25±2.5mm/s Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder
		Appearance	No marking defects	Preheat the capacitor as table. Immerse the capacitor in solder
	Resistance to Soldering	Capacitance Change	Char. Capacitance Change X7R Within ±10% SL Within ±2.5% or ±0.25pF (Whichever is larger)	solution at 260±5°C for 10±1 sec. Let sit at room condition*1 for 24±2 hrs., then measure. •Immersing speed: 25±2.5mm/s •Pretreatment for X7R char. Perform a heat treatment at 150±18°C for 60±5 min. and then
15	Heat	I.R.	More than 1,000M Ω	let sit for 24±2 hrs. at room condition*1.
		Dielectric Strength	In accordance with item No.4	Step Temperature Time 1 100 to 120°C 1 min. 2 170 to 200°C 1 min.

^{*1 &}quot;Room condition" Temperature: 15 to 35 $^{\circ}$ C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

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^{*2 &}quot;C" expresses nominal capacitance value (pF).

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No.	Ite	em	Specifications	Test Method
		Appearance	No marking defects	Fix the capacitor to the supporting jig (glass epoxy board) shown
		Capacitance Change	Char. Capacitance Change X7R Within ±15% SL Within ±2.5% or ±0.25pF (Whichever is larger)	in Fig. 4. Perform the 5 cycles according to the 4 heat treatments listed in the following table. Let sit for 24±2 hrs. at room condition*1, then measure.
17	Temperature	D.F. Q	Char. Specification X7R D.F.≤0.05 SL Q≥400+20C*² (C<30pF)	Step Temperature (°C) Time (min.) 1 Min. Operating Temp.±3 30±3 2 Room Temp. 2 to 3 3 Max. Operating Temp.±2 30±3 4 Room Temp. 2 to 3
16	Cycle	I.R.	More than 3,000M $Ω$	•Pretreatment for X7R char. Perform a heat treatment at 150±18 ℃ for 60±5 min. and then
		Dielectric Strength	In accordance with item No.4	let sit for 24±2 hrs. at room condition*¹. Solder resist
		Appearance	No marking defects	
		Capacitance Change	Char. Capacitance Change X7R Within ±15% SL Within ±5.0% or ±0.5pF (Whichever is larger)	Before this test, the test shown in the following is performedItem 11 Adhesive Strength of Termination (applied force is 5N) -Item 13 Deflection
17	Humidity (Steady State)	D.F. Q	Char. Specification X7R D.F.≤0.05 SL Q≥275+5/2C*² (C<30pF)	Let the capacitor sit at $40\pm2^{\circ}$ C and relative humidity of 90 to 95% for $500^{\pm2^{\circ}_{0}}$ hrs. Remove and let sit for 24 ± 2 hrs. at room condition* ¹ , then measure. •Pretreatment for X7R char.
		I.R.	More than $3{,}000\text{M}\Omega$	Perform a heat treatment at 150 [±] -10°C for 60±5 min. and then let sit for 24±2 hrs. at room condition*¹.
		Dielectric Strength	In accordance with item No.4	let sit tot 2412 ilis. at room condition .
		Appearance Capacitance	No marking defects Char. Capacitance Change X7R Within ±20%	Before this test, the test shown in the following is performed. -Item 11 Adhesive Strength of Termination (apply force is 5N) -Item 13 Deflection
		Change	SL Within ±3.0% or ±0.3pF (Whichever is larger)	Impulse Voltage Each individual capacitor should be subjected to a 2.5kV (Type Front time (T ₁)=1.2μs=1.67T Time to half-value (T ₂)=50μs 100(%) 90 90 90
		D.F. Q	Char. Specification X7R D.F.≤0.05 SL Q≥275+5/2C*² (C<30pF)	be subjected to a 2.5kV (Type GC/GF: 5kV) Impulse (the voltage value means zero to peak) for three times. Then the capacitors are applied to life test.
18	Life	I.R.	More than 3,000MΩ	Apply voltage as Table for 1,000 hrs. at 125 ⁺² 6°C, relative humidity 50% max.
		Dielectric Strength	In accordance with item No.4	Type Applied Voltage GB AC312.5V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec. GC GD GF AC425V (r.m.s.), except that once each hour the voltage is increased to AC1,000V (r.m.s.) for 0.1 sec. Let sit for 24±2 hrs. at room condition*1, then measure. • Pretreatment for X7R char. Perform a heat treatment at 150±18°C for 60±5 min. and then let sit for 24±2 hrs. at room condition*1.

^{*1 &}quot;Room condition" Temperature: 15 to 35 $^{\circ}$ C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

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^{*2 &}quot;C" expresses nominal capacitance value (pF).

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No.	Ite	em	Specifications	Test Method
		Appearance Capacitance Change	No marking defects Char. Capacitance Change X7R Within ±15% SL Within ±5.0% or ±0.5pF (Whichever is larger)	Before this test, the test shown in the following is performedItem 11 Adhesive Strength of Termination (apply force is 5N) -Item 13 Deflection
19	Humidity Loading	D.F. Q	Char. Specification X7R D.F.≦0.05 SL Q≥275+5/2C*² (C<30pF)	Apply the rated voltage at 40±2°C and relative humidity of 90 to 95% for 500 ^{±2} d hrs. Remove and let sit for 24±2 hrs. at room condition*1, then measure. •Pretreatment for X7R char. Perform a heat treatment at 150 [±] 18°C for 60±5 min. and then
		I.R.	More than 3,000MΩ	let sit for 24±2 hrs. at room condition*1.
		Dielectric Strength	In accordance with item No.4	
20	Active		The cheesecloth should not be on fire.	The capacitor should be individually wrapped in at least one but not more than two complete layers of cheesecloth. The capacitor should be subjected to 20 discharges. The interval between successive discharges should be 5 sec. The Uac should be maintained for 2 min. after the last discharge. C1,2: 1μF±10% C3: 0.033μF±5% 10kV L1 to 4: 1.5mH±20% 16A Rod core choke Ct: 3μF±5% 10kV R: 100Ω±2% Cx: Capacitor under test UAC: UR±5% F: Fuse, Rated 16A UR: Rated Voltage Ut: Voltage applied to Ct Type Ui GB, GD CC, GF SkV
21	1 Passive Flammability		The burning time should not exceed 30 sec. The tissue paper should not ignite.	The capacitor under test should be held in the flame in the position which best promotes burning. Each specimen should only be exposed once to the flame. Time of exposure to flame: 30 sec. Length of flame: 12±1mm Gas burner: Length 35mm min. Inside Dia. 0.5±0.1mm Outside Dia. 0.9mm max. Gas: Butane gas Purity 95% min. Test Specimen Tissue About 10mm Thick Board

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